

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/099,626 | Applicant(s)/Patent Under Reexamination SEPPINEN ET AL. | |
| | Examiner Pablo N. Tran | Art Unit 2685 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| | A | US-6,201,953 | 03-2001 | Dwyer, Robert E. | 455/226.1 |
| | B | US-5,949,372 | 09-1999 | Lennen, Gary R. | 342/357.02 |
| | C | US-6,225,848 | 05-2001 | Tilley et al. | 327/307 |
| | D | US-6,704,352 | 03-2004 | Johnson, Mitchell K. | 375/224 |
| | E | US-2004/0002318 | 01-2004 | Kerth et al. | 455/302 |
| | F | US-2003/0231723 | 12-2003 | Hansen, Christopher J. | 375/343 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.